

Data sheet acquired from Harris Semiconductor SCHS185C

September 1997 - Revised October 2003

# High-Speed CMOS Logic Dual Decade Ripple Counter

#### **Features**

- Two BCD Decade or Bi-Quinary Counters
- One Package Can Be Configured to Divide-by-2, 4, 5,10, 20, 25, 50 or 100
- Two Master Reset Inputs to Clear Each Decade Counter Individually
- Fanout (Over Temperature Range)
- Wide Operating Temperature Range . . . -55°C to 125°C
- Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- HC Types
  - 2V to 6V Operation
  - High Noise Immunity:  $N_{IL}$  = 30%,  $N_{IH}$  = 30% of  $V_{CC}$  at  $V_{CC}$  = 5V
- HCT Types
  - 4.5V to 5.5V Operation
  - Direct LSTTL Input Logic Compatibility,
     V<sub>II</sub> = 0.8V (Max), V<sub>IH</sub> = 2V (Min)
  - CMOS Input Compatibility,  $I_I \le 1 \mu A$  at  $V_{OL}$ ,  $V_{OH}$

### Description

The CD74HC390 and 'HCT390 dual 4-bit decade ripple counters are high-speed silicon-gate CMOS devices and are pin compatible with low-power Schottky TTL (LSTTL). These devices are divided into four separately clocked sections. The counters have two divide-by-2 sections and two divide-by-5 sections. These sections are normally used in a BCD decade or bi-quinary configuration, since they share a common master reset (nMR). If the two master reset inputs (1MR and 2MR) are used to simultaneously clear all 8 bits of the counter, a number of counting configurations are possible within one package. The separate clock inputs ( $n\overline{CP0}$  and  $n\overline{CP1}$ ) of each section allow ripple counter or frequency division applications of divide-by-2, 4. 5, 10, 20, 25, 50 or 100. Each section is triggered by the High-to-Low transition of the input pulses ( $n\overline{CP0}$  and  $n\overline{CP1}$ ).

For BCD decade operation, the nQ0 output is connected to the n $\overline{CP1}$  input of the divide-by-5 section. For bi-quinary decade operation, the nO3 output is connected to the n $\overline{CP0}$  input and nQ0 becomes the decade output.

The master reset inputs (1MR and 2MR) are active-High asynchronous inputs to each decade counter which operates on the portion of the counter identified by the "1" and "2" prefixes in the pin configuration. A High level on the nMR input overrides the clock and sets the four outputs Low.

## **Ordering Information**

PART NUMBER	TEMP. RANGE (°C)	PACKAGE
CD54HCT390F3A	-55 to 125	16 Ld CERDIP
CD74HC390E	-55 to 125	16 Ld PDIP
CD74HC390M	-55 to 125	16 Ld SOIC
CD74HC390MT	-55 to 125	16 Ld SOIC
CD74HC390M96	-55 to 125	16 Ld SOIC
CD74HCT390E	-55 to 125	16 Ld PDIP
CD74HCT390M	-55 to 125	16 Ld SOIC
CD74HCT390MT	-55 to 125	16 Ld SOIC
CD74HCT390M96	-55 to 125	16 Ld SOIC

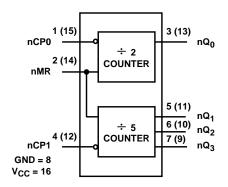
NOTE: When ordering, use the entire part number. The suffix 96 denotes tape and reel. The suffix T denotes a small-quantity reel of 250.

## **Pinout**

CD54HCT390 (CERDIP) CD74HC390, CD74HCT390 (PDIP, SOIC) TOP VIEW

1CP0 [	1		16 V <sub>CC</sub>
1MR	2	į	15 2CP0
1Q <sub>0</sub> [	3	į	14 2MR
1 <u>CP1</u> [	4	[	13 2Q0
1Q <sub>1</sub>	5	[	12 2CP1
1Q <sub>2</sub>	6		11 2Q <sub>1</sub>
1Q <sub>3</sub>	7		10 2Q <sub>2</sub>
GND [	8		9 2Q <sub>3</sub>

# Functional Diagram



### TRUTH TABLE

INF	PUTS	
СР	MR	ACTION
1	L	No Change
<b>\</b>	L	Count
Х	Н	All Qs Low

#### **BCD COUNT SEQUENCE FOR 1/2 THE 390**

		OUTPUTS									
COUNT	Q0	Q1	Q2	Q3							
0	L	L	L	L							
1	Н	L	L	L							
2	L	Н	L	L							
3	Н	Н	L	L							
4	L	L	Н	L							
5	Н	L	Н	L							
6	L	Н	Н	L							
7	Н	Н	Н	L							
8	L	L	L	Н							
9	Н	L	L	Н							

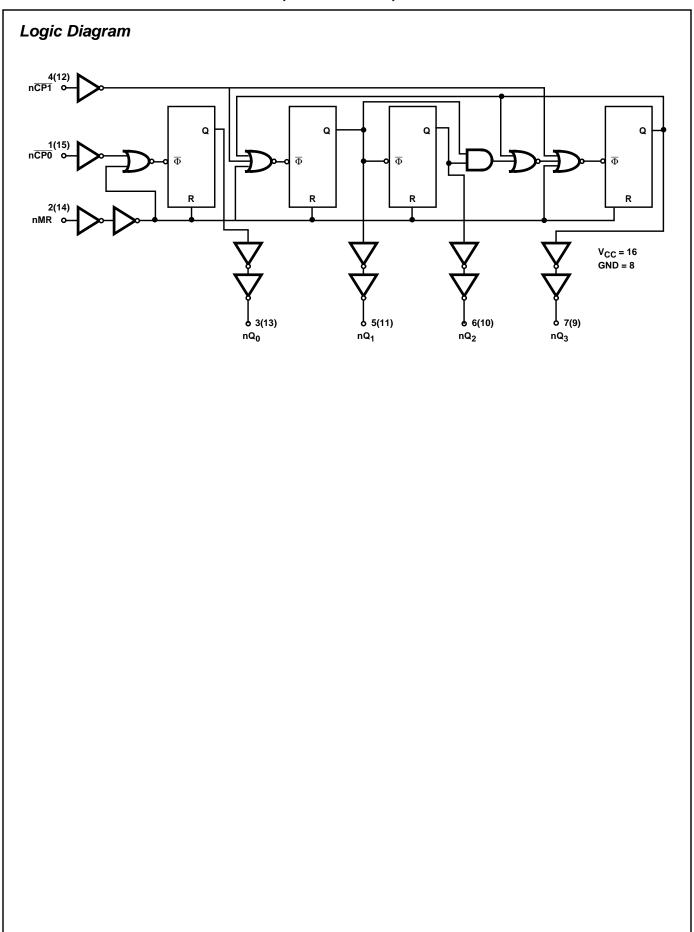
Output nQ0 connected to  $n\overline{CP1}$  with counter input on  $n\overline{CP0}$ .

#### **B-QUINARY COUNT SEQUENCE FOR 1/2 THE 390**

		OUTI	PUTS	
COUNT	Q0	Q1	Q2	Q3
0	L	L	L	L
1	L	Н	L	L
2	L	L	Н	L
3	L	Н	Н	L
4	L	L	L	Н
5	Н	L	L	L
6	Н	Н	Н	L
7	Н	L	Н	L
8	Н	Н	Н	L
9	Н	L	L	Н

Output nQ3 connected to  $n\overline{CP0}$  with counter input on  $n\overline{CP1}$ .

$$<sup>\</sup>label{eq:hamiltonian} \begin{split} H &= \text{High Voltage Level}, \, L = \text{Low Voltage Level}, \, X = \text{Don't Care}, \\ \uparrow &= \text{Transition from Low to High Level}, \, \downarrow = \text{Transition from High to Low}. \end{split}$$



### **Absolute Maximum Ratings**

#### 

#### **Thermal Information**

Thermal Resistance (Typical, Note 1)	$\theta_{JA}$ (°C/W)
E (PDIP) Package	67
M (SOIC) Package	
Maximum Junction Temperature	
Maximum Storage Temperature Range	65°C to 150°C
Maximum Lead Temperature (Soldering 10s)	300°C
(SOIC - Lead Tips Only)	

#### **Operating Conditions**

Temperature Range (T <sub>A</sub> )55°C to 125°C
Supply Voltage Range, V <sub>CC</sub>
HC Types2V to 6V
HCT Types
DC Input or Output Voltage, V <sub>I</sub> , V <sub>O</sub> 0V to V <sub>CC</sub>
Input Rise and Fall Time
2V
4.5V 500ns (Max)
6V

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

#### NOTE:

1. The package thermal impedance is calculated in accordance with JESD 51-7.

### **DC Electrical Specifications**

		TEST CONDITIONS		TEST CONDITIONS		1		1		v <sub>cc</sub>		25°C		-40°C 1	O 85°C	-55°C T	O 125°C	
PARAMETER	SYMBOL	V <sub>I</sub> (V)	I <sub>O</sub> (mA)		MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS						
HC TYPES																		
High Level Input	V <sub>IH</sub>	-	-	2	1.5	-	-	1.5	-	1.5	-	V						
Voltage				4.5	3.15	•	-	3.15	-	3.15	-	V						
				6	4.2	•	-	4.2	-	4.2	-	V						
Low Level Input	V <sub>IL</sub>	-	-	2	-	-	0.5	-	0.5	-	0.5	V						
Voltage				4.5	-	-	1.35	-	1.35	-	1.35	V						
				6	-	-	1.8	-	1.8	-	1.8	V						
High Level Output	V <sub>OH</sub>	V <sub>IH</sub> or V <sub>IL</sub>	-0.02	2	1.9	-	-	1.9	-	1.9	-	V						
Voltage CMOS Loads						-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V			
omeo Loado			-0.02	6	5.9	-	-	5.9	-	5.9	-	V						
High Level Output	7				-	-	-	-	-	-	-	-	-	V				
Voltage TTL Loads			-4	4.5	3.98	-	-	3.84	-	3.7	-	V						
			-5.2	6	5.48	-	-	5.34	-	5.2	-	V						
Low Level Output	V <sub>OL</sub>	V <sub>IH</sub> or V <sub>IL</sub>	0.02	2	-	-	0.1	-	0.1	-	0.1	V						
Voltage CMOS Loads			0.02	4.5	-	-	0.1	-	0.1	-	0.1	V						
						0.02	6	-	-	0.1	-	0.1	-	0.1	V			
Low Level Output	1		-	-	-	-	-	-	-	-	-	V						
Voltage TTL Loads			4	4.5	-	-	0.26	-	0.33	-	0.4	V						
112 20000			5.2	6	-	-	0.26	-	0.33	-	0.4	V						
Input Leakage Current	II	V <sub>CC</sub> or GND	-	6	-	-	±0.1	-	±1	-	±1	μΑ						
Quiescent Device Current	Icc	V <sub>CC</sub> or GND	0	6	-	-	8	-	80	-	160	μΑ						

## DC Electrical Specifications (Continued)

		TE: CONDI	_	Vcc		25°C		-40°C 1	O 85°C	-55°C T	O 125°C				
PARAMETER	SYMBOL	V <sub>I</sub> (V)	I <sub>O</sub> (mA)	(S)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS			
HCT TYPES															
High Level Input Voltage	V <sub>IH</sub>	-	-	4.5 to 5.5	2	-	-	2	-	2	-	V			
Low Level Input Voltage	V <sub>IL</sub>	-	-	4.5 to 5.5	-	-	0.8	-	0.8	-	0.8	V			
High Level Output Voltage CMOS Loads	Voн	V <sub>IH</sub> or V <sub>IL</sub>	-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V			
High Level Output Voltage TTL Loads			-4	4.5	3.98	-	-	3.84	-	3.7	-	V			
Low Level Output Voltage CMOS Loads	V <sub>OL</sub>	V <sub>IH</sub> or V <sub>IL</sub>	0.02	4.5	-	-	0.1	-	0.1	-	0.1	V			
Low Level Output Voltage TTL Loads			4	4.5	-	-	0.26	-	0.33	-	0.4	V			
Input Leakage Current	lį	V <sub>CC</sub> and GND	0	5.5	-	-	±0.1	-	±1	-	±1	μΑ			
Quiescent Device Current	Icc	V <sub>CC</sub> or GND	0	5.5	-	-	8	-	80	-	160	μА			
Additional Quiescent Device Current Per Input Pin: 1 Unit Load	ΔI <sub>CC</sub> (Note 2)	V <sub>CC</sub> -2.1	-	4.5 to 5.5	-	100	360	-	450	-	490	μΑ			

### NOTE:

### **HCT Input Loading Table**

INPUT	UNIT LOADS
n <del>CP0</del>	0.45
nCP1, MR	0.6

NOTE: Unit Load is  $\Delta I_{CC}$  limit specified in DC Electrical Table, e.g., 360µA max at  $25^{\rm o}C.$ 

## **Prerequisite for Switching Specifications**

			25°C			-40°C TO 85°C		-55°C TO 125°C		
CHARACTERISTIC	SYMBOL	V <sub>CC</sub> (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES								-		
Maximum Clock	f <sub>MAX</sub>	2	6	-	-	5	-	4	-	MHz
Frequency		4.5	30	-	-	24	-	20	-	MHz
		6	35	-	-	28	-	24	-	MHz
Clock Pulse Width,	t <sub>W</sub>	2	80	-	-	100	-	120	-	ns
nCP0, nCP1		4.5	16	-	-	20	-	24	-	ns
		6	14	-	-	17	-	20	-	ns

<sup>2.</sup> For dual-supply systems theoretical worst case ( $V_I = 2.4V$ ,  $V_{CC} = 5.5V$ ) specification is 1.8mA.

# Prerequisite for Switching Specifications (Continued)

			25°C			-40°C 1	O 85°C	-55°C T		
CHARACTERISTIC	SYMBOL	V <sub>CC</sub> (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
Reset Removal Time	t <sub>REM</sub>	2	70	_	-	90	-	105	-	ns
		4.5	14	-	-	18	-	21	-	ns
		6	12	-	-	15	-	18	-	ns
Reset Pulse Width	t <sub>W</sub>	2	50	-	-	65	-	75	-	ns
		4.5	10	-	-	13	-	15	-	ns
		6	9	-	-	11	-	13	-	ns
HCT TYPES	•		•					•		
Maximum Clock Frequency	f <sub>MAX</sub>	4.5	27	-	-	22	-	18	-	MHz
Clock Pulse Width, nCP0, nCP1	t <sub>W</sub>	4.5	19	-	-	24	-	29	-	ns
Reset Removal Time	t <sub>REM</sub>	4.5	15	-	-	19	-	22	-	ns
Reset Pulse Width	t <sub>W</sub>	4.5	13	-	-	16	-	20	-	ns

# Switching Specifications Input $t_{\text{r}}, \, t_{\text{f}} = 6 \text{ns}$

		TEST	v <sub>cc</sub>		25°C		-40°C	го 85°С	-55°C TO 125°C		
PARAMETER	SYMBOL	CONDITIONS	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES											
Propagation Delay (Figure 1)	t <sub>PLH</sub> ,	C <sub>L</sub> = 50pF	2	-	-	175	-	220	-	265	ns
$n\overline{CP0}$ to $nQ_0$	t <sub>PHL</sub>		4.5	-	-	35	-	44	-	53	ns
		C <sub>L</sub> =15pF	5	-	14	-	-	-	-	-	ns
		C <sub>L</sub> = 50pF	6	-	-	30	-	37	-	45	ns
nCP1 to nQ <sub>1</sub>	t <sub>PLH</sub> ,	C <sub>L</sub> = 50pF	2	-	-	185	-	230	-	280	ns
	t <sub>PHL</sub>		4.5	-	-	37	-	46	-	56	ns
			6	-	-	31	-	39	-	48	ns
nCP1 to nQ <sub>2</sub>	<sup>t</sup> PLH, <sup>t</sup> PHL	C <sub>L</sub> = 50pF	2	-	-	245	-	305	-	370	ns
			4.5	-	-	49	-	61	-	74	ns
			6	-	-	42	-	52	-	63	ns
nCP1 to nQ <sub>3</sub>	t <sub>PLH,</sub> t <sub>PHL</sub>	C <sub>L</sub> = 50pF	2	-	-	180	-	225	-	270	ns
			4.5	-	-	36	-	45	-	54	ns
			5	-	15	-	-	-	-	-	ns
			6	-	-	31	-	38	-	46	ns
nCP0 to nQ3	t <sub>PLH</sub> ,	C <sub>L</sub> = 50pF	2	-	-	365	-	455	-	550	ns
$(nQ_0 \text{ connected to } n\overline{CP1})$	t <sub>PHL</sub>		4.5	-	-	73	-	91	-	110	ns
			6	-	-	62	-	77	-	94	ns
MR to Q <sub>n</sub>	t <sub>PLH</sub> ,	C <sub>L</sub> = 50pF	2	-	-	190	-	240	-	285	ns
	t <sub>PHL</sub>		4.5	-	-	38	-	48	-	57	ns
		C <sub>L</sub> =15pF	5	-	16	-	-	-	-	-	ns
		C <sub>L</sub> = 50pF	6	-	-	32	-	41	-	48	ns

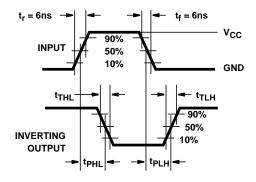
## Switching Specifications Input $t_r$ , $t_f$ = 6ns (Continued)

		TEST V <sub>CC</sub> 25°C			-40°C T	O 85°C	-55°C T	) 125°C			
PARAMETER	SYMBOL	CONDITIONS	(v)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
Output Transition Time	t <sub>TLH</sub> , t <sub>THL</sub>	C <sub>L</sub> = 50pF	2	-	-	75	-	95	-	110	ns
(Figure 1)			4.5	-	-	15	-	19	-	22	ns
			6	-	-	13	-	16	-	19	ns
Input Capacitance	C <sub>IN</sub>	C <sub>L</sub> = 50pF	-	-	-	10	-	10	-	10	pF
Power Dissipation Capacitance (Notes 3, 4)	C <sub>PD</sub>	C <sub>L</sub> =15pF	5	-	28	-	-	-	-	-	pF
HCT TYPES	•							•	•	•	
Propagation Delay (Figure 1)	t <sub>PLH</sub> ,	C <sub>L</sub> = 50pF	4.5	-	-	40	-	50	-	60	ns
n <del>CP0</del> to nQ <sub>0</sub>	<sup>t</sup> PHL	C <sub>L</sub> =15pF	5	-	17	-	-	-	-	-	ns
nCP1 to nQ <sub>1</sub>	t <sub>PLH,</sub>	C <sub>L</sub> = 50pF	4.5	-	-	43	-	51	-	65	ns
nCP1 to nQ <sub>2</sub>	t <sub>PLH,</sub>	C <sub>L</sub> = 50pF	4.5	-	-	55	-	69	-	83	ns
nCP1 to nQ <sub>3</sub>	t <sub>PLH,</sub> t <sub>PHL</sub>	C <sub>L</sub> = 50pF	4.5	-	-	42	-	53	-	63	ns
		C <sub>L</sub> =15pF	5	-	18	-	-	-	-	-	ns
nCP0 to nQ2 (nQ <sub>0</sub> connected to nCP1)	t <sub>PLH,</sub> t <sub>PHL</sub>	C <sub>L</sub> = 50pF	4.5	-	-	84	-	105	-	126	ns
MR to Q <sub>n</sub>	t <sub>PLH,</sub>	C <sub>L</sub> = 50pF	4.5	-	-	42	-	53	-	63	ns
	<sup>t</sup> PHL	C <sub>L</sub> =15pF	5	-	18	-	-	-	-	-	ns
Output Transition	t <sub>TLH</sub> , t <sub>THL</sub>	C <sub>L</sub> = 50pF	4.5	-	-	15	-	19	-	22	ns
Input Capacitance	C <sub>IN</sub>	C <sub>L</sub> =15pF	-	-	-	10	-	10	-	10	pF
Power Dissipation Capacitance (Notes 3, 4)	C <sub>PD</sub>	C <sub>L</sub> =15pF	5	-	32	-	-	-	-	-	pF

#### NOTES:

- 3.  $C_{\mbox{\scriptsize PD}}$  is used to determine the dynamic power consumption, per multiplexer.
- 4.  $P_D = V_{CC}^2 f_i (C_{PD} + C_L)$  where  $f_i$  = Input Frequency,  $C_L$  = Output Load Capacitance,  $V_{CC}$  = Supply Voltage.

## Test Circuits and Waveforms





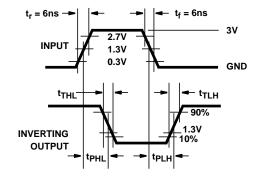


FIGURE 2. HCT TRANSITION TIMES AND PROPAGATION DELAY TIMES, COMBINATION LOGIC



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## **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
5962-9098401MEA	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type
CD54HCT390F3A	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type
CD74HC390E	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74HC390EE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74HC390M	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HC390M96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HC390M96E4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HC390M96G4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HC390ME4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HC390MG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HC390MT	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HC390MTE4	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HC390MTG4	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HCT390E	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74HCT390EE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74HCT390M	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HCT390M96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HCT390M96E4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HCT390M96G4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HCT390ME4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HCT390MG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HCT390MT	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HCT390MTE4	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HCT390MTG4	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

(1) The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs. **LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.



#### PACKAGE OPTION ADDENDUM

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**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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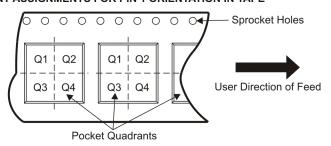
### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HC390M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74HCT390M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1





\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HC390M96	SOIC	D	16	2500	333.2	345.9	28.6
CD74HCT390M96	SOIC	D	16	2500	333.2	345.9	28.6

## 14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

# N (R-PDIP-T\*\*)

## PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN

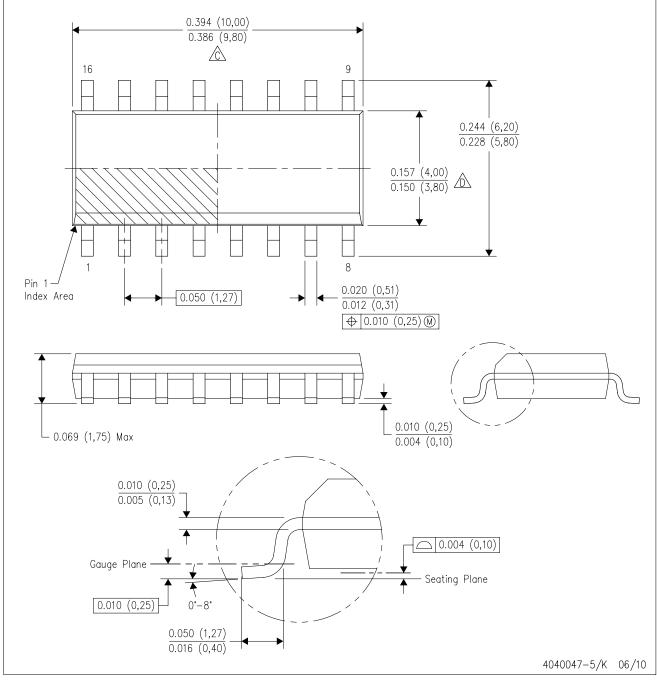


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



# D (R-PDS0-G16)

## PLASTIC SMALL-OUTLINE PACKAGE

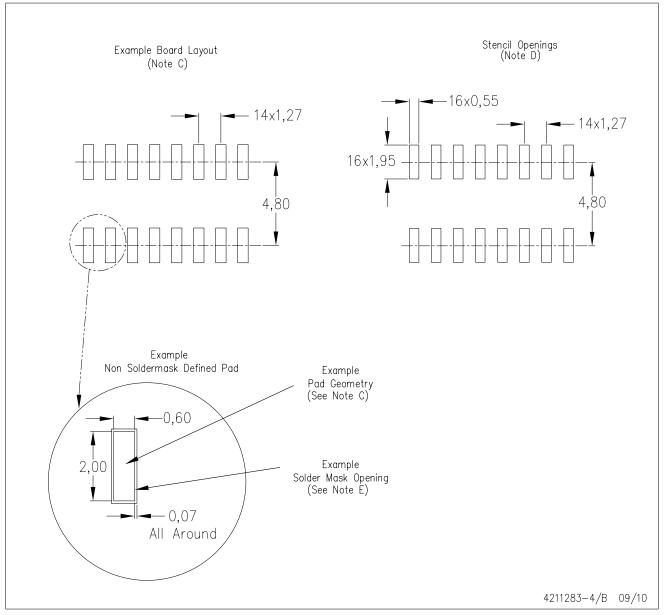


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.
- Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.
- E. Reference JEDEC MS-012 variation AC.



# D (R-PDSO-G16)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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